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14 2A4

13 20E

DB, DW, OR NT PACKAGE Inputs Are TTL-Voltage Compatible (TOP VIEW) Flow-Through Architecture Optimizes **PCB Layout** 24 1 10E 1Y1 Center-Pin V_{CC} and GND Configurations 1Y2 **∏**2 23 1A1 **Minimize High-Speed Switching Noise** 1Y3 **∏**3 22 1 1A2 **EPIC**™ (Enhanced-Performance Implanted 21 1 1A3 1Y4 [CMOS) 1-µm Process GND II 5 20 1 1A4 19 V_{CC} 500-mA Typical Latch-Up Immunity at GND ∏6 18**∏** V_{CC} GND [GND I 17 1 2A1 **Package Options Include Plastic** 2Y1 **∏**9 16 2A2 Small-Outline (DW) and Shrink 2Y2 110 15 2A3 Small-Outline (DB) Packages, and Standard

description

Plastic 300-mil DIPs (NT)

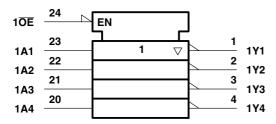
This octal buffer or line driver is designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. This device provides inverting outputs and symmetrical active-low output-enable (\overline{OE}) inputs. This device features high fan-out and improved fan-in.

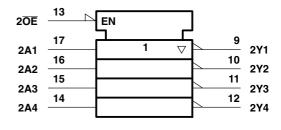
The 74ACT11240 is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each buffer)

INPL	JTS	OUTPUT
ŌĒ	Α	Υ
L	Н	L
L	L	Н
Н	Χ	Z

logic symbol†





2Y3 **1**11

2Y4 **1**12



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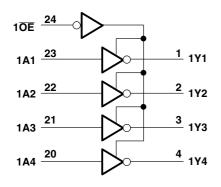
EPIC is a trademark of Texas Instruments Incorporated

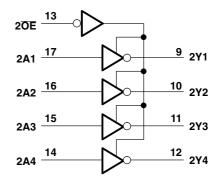


[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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logic diagram (positive logic)





absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	–0.5 V to 6 V
Input voltage range, V _I (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, V _O (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, $I_O(V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±200 mA
Maximum power dissipation at T _A = 55°C (in still air) (see Note 2): DB package	0.65 W
DW package	1.7 W
NT package	1.3 W
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils, except for the NT package, which has a trace length of zero.

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage			8.0	V
V _I	Input voltage	0		V_{CC}	V
V _O	Output voltage	0		V_{CC}	V
I _{OH}	High-level output current			-24	mA
l _{OL}	Low-level output current			24	mA
Δt/Δν	Input transition rise or fall rate	0		10	ns/V
T _A	Operating free-air temperature	-40		85	°C



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST COMPITIONS		T	_A = 25°C	;			
PARAMETER	TEST CONDITIONS	v _{cc}	MIN	TYP	MAX	MIN	MAX	UNIT
	- FO. A	4.5 V	4.4			4.4		
	$I_{OH} = -50 \mu A$	5.5 V	5.4			5.4		V
V _{OH}	04 mA	4.5 V	3.94			3.8		
	$I_{OH} = -24 \text{ mA}$	5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	- FO A	4.5 V			0.1		0.1	
	$I_{OL} = 50 \mu A$	5.5 V			0.1		0.1	
V _{OL}	04 = 4	4.5 V			0.36		0.44	V
	I _{OL} = 24 mA	5.5 V			0.36		0.44	
	$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V					1.65	
l _{OZ}	$V_O = V_{CC}$ or GND	5.5 V			±0.5		±5	μΑ
I _I	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1	μΑ
I _{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			8		80	μΑ
Δ l _{CC} ‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V		•	0.9		1	mA
C _i	$V_I = V_{CC}$ or GND	5 V		4				pF
Co	$V_I = V_{CC}$ or GND	5 V		10				pF

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

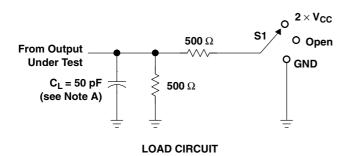
DADAMETED	FROM	то	T,	_A = 25°C	;	MAINI	мах	
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN		UNIT
t _{PLH}	_	V	1.5	6.5	9.9	1.5	10.6	
t _{PHL}	A	Ť	1.5	6	8	1.5	8.7	ns
t _{PZH}	- OE	V	1.5	7.5	11.7	1.5	12.5	
t _{PZL}	OE .	Ť	1.5	7.3	11.5	1.5	12.3	ns
t _{PHZ}	 OE	V	1.5	7.3	9.4	1.5	10	
t _{PLZ}) UE	T T	1.5	7.9	10.3	1.5	10.8	ns

operating characteristics, V_{CC} = 5 V, T_A = 25°C

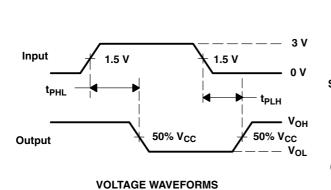
	PARAMETER	TEST CON	TYP	UNIT		
	Decree discipation considers a marketter	Outputs enabled	0 50 5	4 4 1 4 1 1 -	47	
C_{pd}	Power dissipation capacitance per buffer	Outputs disabled	$C_L = 50 \text{ pF},$	f = 1 MHz	13	pF

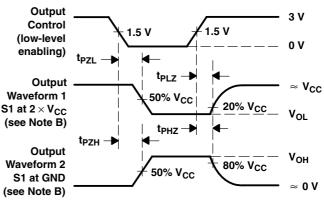
[‡] This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

PARAMETER MEASUREMENT INFORMATION



TEST	S1
t _{PLH} /t _{PHL}	Open
t_{PLZ}/t_{PZL}	$2\times\mathbf{V_{CC}}$
t _{PHZ} /t _{PZH}	GND





VOLTAGE WAVEFORMS

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_r = 3 \ ns$, $t_f = 3 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
74ACT11240DW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	ACT11240	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
74ACT11240DW	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



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